

P-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)	
- 100	0.043 at $V_{GS} = -10 \text{ V}$	- 40	35	
	0.050 at V _{GS} = - 4.5 V	- 30	33	

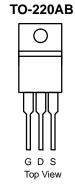
FEATURES

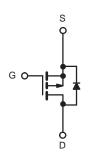
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested



APPLICATIONS

- Power Switch
- DC/DC Converters
- Portable equipment and battery powered systems





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_C = 25 ^{\circ}C$, unless oth	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 100	V	
Gate-Source Voltage		V _{GS}	± 20	V	
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C	I _D	- 40	A	
Continuous Brain Current (1) = 150 C)	T _C = 70 °C	'D	- 35		
Pulsed Drain Current		I _{DM}	I _{DM} - 160		
Avalanche Current		I _{AS}	- 36	1	
ingle Avalanche Energy ^a L = 0.1 mH		E _{AS}	39	mJ	
Maximum Power Dissipation ^a	T _C = 25 °C	P _D	120 ^b	W	
	T _A = 25 °C ^c	TD FD	3.8		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Limit	Unit	
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	50	°C/W	
Junction-to-Case (Drain)	R _{thJC}	2.2		

Notes:

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.
- c. When Mounted on 1" square PCB (FR-4 material).



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	·					
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 100			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3.5	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 250	nA
Zero Gate Voltage Drain Current		V _{DS} = - 80 V, V _{GS} = 0 V			- 1	
	I _{DSS}	V _{DS} = -80 V, V _{GS} = 0 V, T _J = 125 °C			- 50	μΑ
		V _{DS} = - 80 V, V _{GS} = 0 V, T _J = 150 °C			- 250	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 160			Α
	<u> </u>	V _{GS} = - 10 V, I _D = - 5 A		0.043	0.051	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 3 A		0.050	0.065	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 15 V, I _D = - 5 A		17		S
Dynamic ^b	·					
Input Capacitance	C _{iss}			8510		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = - 50 V, f = 1 MHz		1405		
Reverse Transfer Capacitance	C _{rss}]		504		
Total Cata Charge		V _{DS} = -50 V, V _{GS} = -10 V, I _D = -5 A		35		
Total Gate Charge ^c	Qg			15		~C
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3 \text{ A}$		8		nC
Gate-Drain Charge ^c	Q _{gd}			6		
Gate Resistance	R _g	f = 1 MHz	1.2	5.7	11.5	Ω
Turn-On Delay Time ^c	t _{d(on)}			18		
Rise Time ^c	t _r	$V_{DD} = -50 \text{ V}, R_L = 17.2 \Omega$ $I_D \cong -2.9 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		22		ns
Turn-Off Delay Time ^c	t _{d(off)}			49		
Fall Time ^c	t _f]		13.5		
Drain-Source Body Diode Ratings ar	nd Characteri	stics T _C = 25 °C ^b				
Continuous Current	I _S				- 40	^
Pulsed Current	I _{SM}				-160	A
Forward Voltage ^a	V _{SD}	I _F = - 2.9 A, V _{GS} = 0 V		- 0.7	- 1.5	V
Reverse Recovery Time	t _{rr}			50		ns
Peak Reverse Recovery Current	I _{RM(REC)}	I _F = - 2.9 A, dl/dt = 100 A/μs		- 4	- 6	Α
Reverse Recovery Charge	Q _{rr}	1		98	147	nC

Notes:

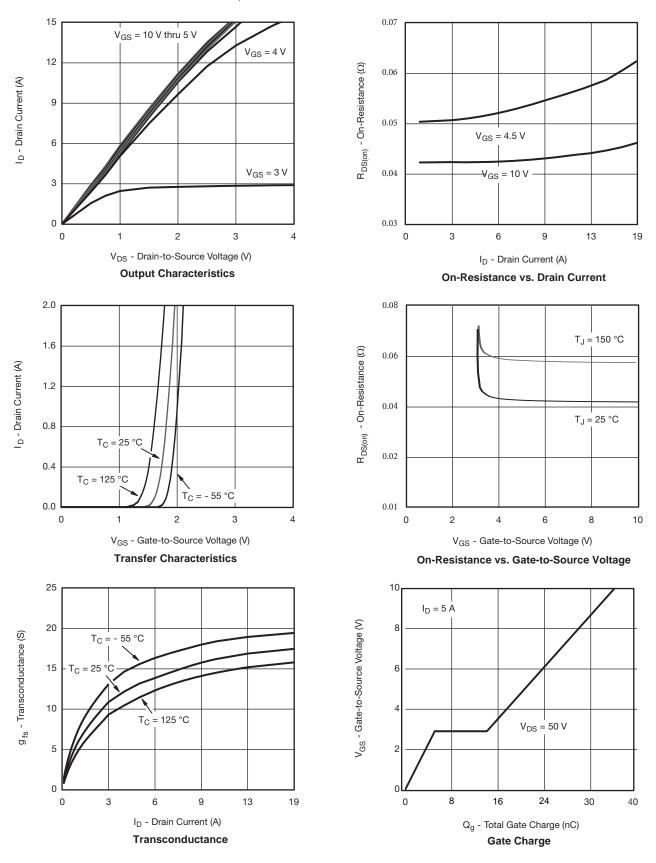
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



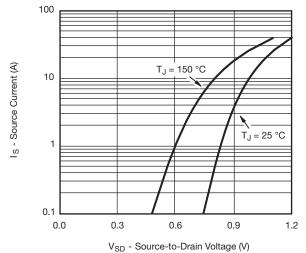


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

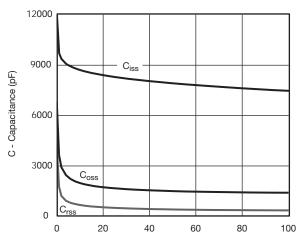




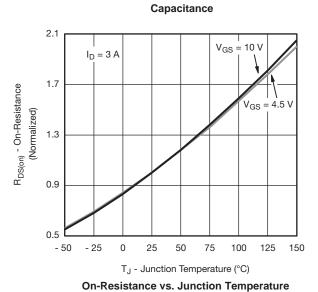
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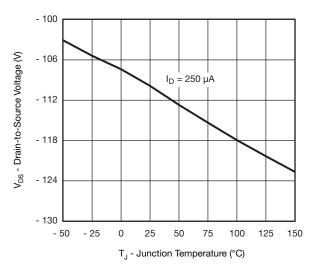
Source-Drain Diode Forward Voltage



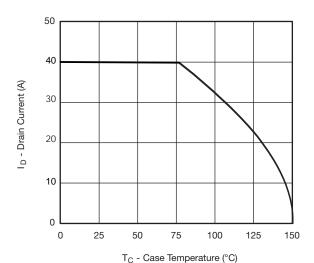
 V_{DS} - Drain-to-Source Voltage (V)



Threshold Voltage



Drain Source Breakdown vs. Junction Temperature

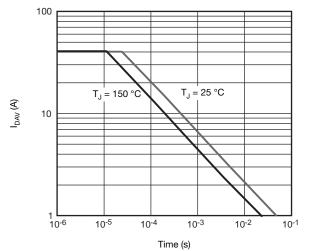


Current Derating

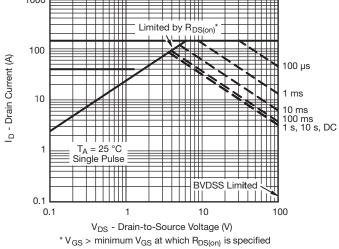




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Single Pulse Avalanche Current Capability vs. Time





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